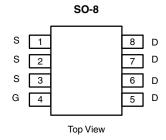




Vishay Siliconix

P-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$ Max.	I _D (A) ^d	Q _g (Typ.)		
- 30	0.0060 at V _{GS} = - 10 V	- 25.7	65 nC		
- 30	0.0080 at V _{GS} = - 4.5 V	- 22.3	65 110		



Ordering Information:

Si4101DY-T1-GE3 (Lead (Pb)-free and Halogen-free)

FEATURES

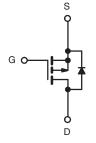
- TrenchFET® Power MOSFET
- 100 % R_a and UIS Tested
- Material categorization: For definitions of compliance please see www.vishay.com/doc?99912



HALOGEN FREE

APPLICATIONS

- · Adaptor Switch, Load Switch
- **Power Management**
- Notebook Computers and Portable Battery Packs



P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (7	$\Gamma_A = 25 ^{\circ}\text{C}$, unless oth	erwise noted)	
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	- 30	V	
Gate-Source Voltage	V _{GS}	± 20	v	
	T _C = 25 °C		- 25.7	
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C	l ₁₋	- 20.6	
Continuous Diam Current (1) = 130 °C)	T _A = 25 °C	l lD	- 18 ^{a, b}	
	T _A = 70 °C	1	- 14.4 ^{a, b}	Α
Pulsed Drain Current (t = 300 μs)	I _{DM}	- 70	A	
Continuous Source-Drain Diode Current	T _C = 25 °C	I.	- 5	
Continuous Source-Drain Diode Current	T _A = 25 °C	l _S	- 2.4 ^{a, b}	
Avalanche Current	1 0.4 ml 1	I _{AS}	- 30	
Single-Pulse Avalanche Energy	L = 0.1 mH	E _{AS}	45	mJ
	T _C = 25 °C		6	
Maximum Dawar Dissination	T _C = 70 °C	P _D	3.8	w
Maximum Power Dissipation	T _A = 25 °C		2.9 ^{a, b}	VV
	T _A = 70 °C	1	1.9 ^{a, b}	
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{a, c}	t ≤ 10 s	R_{thJA}	36	43	°C/W	
Maximum Junction-to-Foot	Steady State	R_{thJF}	16	21	C/VV	

Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- b. t = 10 s.
- c. Maximum under steady state conditions is 84 °C/W.
- d. Based on T_C = 25 °C.

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = - 250 μA		- 20		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	1 _D = - 250 μΑ		5.3		miv/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 1		- 2.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zava Cata Valtaga Drain Current	I	V _{DS} = - 30 V, V _{GS} = 0 V			- 1		
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			- 5	μΑ	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge -10 \text{ V}, V_{GS} = -10 \text{ V}$	- 30			Α	
	_	V _{GS} = - 10 V, I _D = - 15 A		0.0050	0.0060	.0060	
Drain-Source On-State Resistance ^a	$R_{DS(on)}$	V _{GS} = - 4.5 V, I _D = - 10 A	0.0066 0.008		0.0080	Ω	
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 10 V, I _D = - 15 A		72		S	
Dynamic ^b							
Input Capacitance	C _{iss}			8190		pF	
Output Capacitance	C _{oss}	V _{DS} = - 15 V, V _{GS} = 0 V, f = 1 MHz		772			
Reverse Transfer Capacitance	C _{rss}			715			
Tabal Oaks Observe		V _{DS} = - 15 V, V _{GS} = - 10 V, I _D = - 18 A		135	203		
Total Gate Charge	Q_g			65	85		
Gate-Source Charge	Q _{gs}	$V_{DS} = -15 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -18 \text{ A}$		22.5		nC	
Gate-Drain Charge	Q_{gd}			17.6			
Gate Resistance	R _q	f = 1 MHz	0.4	2	4	Ω	
Turn-On Delay Time	t _{d(on)}			20	30		
Rise Time	ì,	$V_{DD} = -15 \text{ V}, R_{L} = 1.5 \Omega$		9	18		
Turn-Off DelayTime	t _{d(off)}	$I_D \cong$ - 10 A, V_{GEN} = - 10 V, R_g = 1 Ω		80	120		
Fall Time	t _f			11	20	1	
Turn-On Delay Time	t _{d(on)}			72	108	ns	
Rise Time	ì,	$V_{DD} = -15 \text{ V}, R_{L} = 1.5 \Omega$		60	90		
Turn-Off DelayTime	t _{d(off)}	$I_D \cong$ - 10 A, V_{GEN} = - 4.5 V, R_g = 1 Ω		60	90		
Fall Time	t _f	·		23	35		
Drain-Source Body Diode Characteris	tics	,		•			
Continous Source-Drain Diode Current	I _S	T _C = 25 °C			- 5		
Pulse Diode Forward Current	I _{SM}				- 70	Α	
Body Diode Voltage	V _{SD}	I _S = - 3 A, V _{GS} = 0 V		- 0.78	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			29	45	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	1 40 A 31/31 400 A/32 T 05 20		19	29	nC	
Reverse Recovery Fall Time	t _a	$I_F = -10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 °\text{C}$		13		1	
Reverse Recovery Rise Time	t _b	_		16		ns	

Notes:

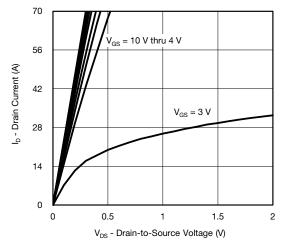
- a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

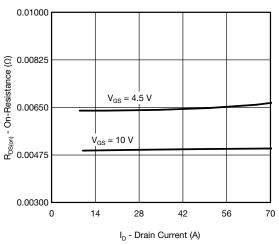


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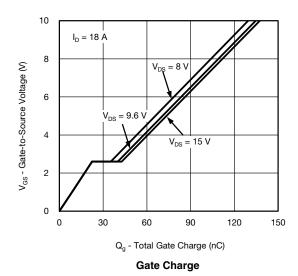
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

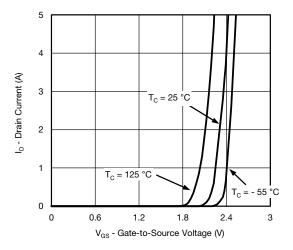


Output Characteristics

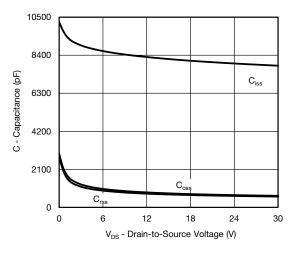


On-Resistance vs. Drain Current

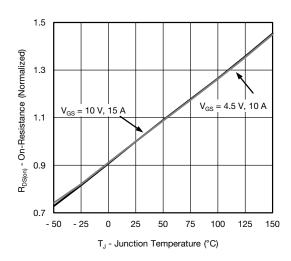




Transfer Characteristics



Capacitance



On-Resistance vs. Junction Temperature

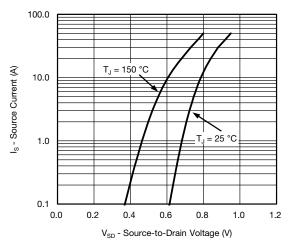
0.014

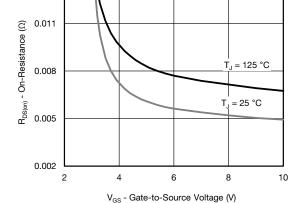
Si4101DY

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I_D = 15 A

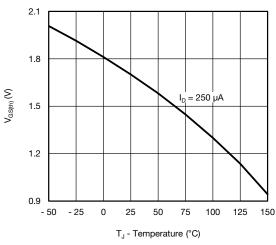
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

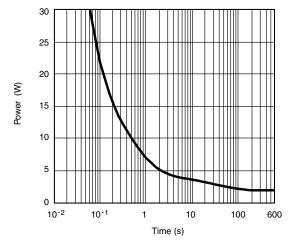




Source-Drain Diode Forward Voltage

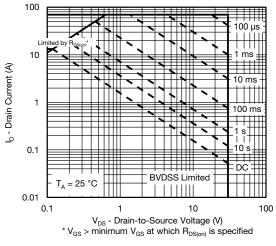
On-Resistance vs. Gate-to-Source Voltage





Threshold Voltage

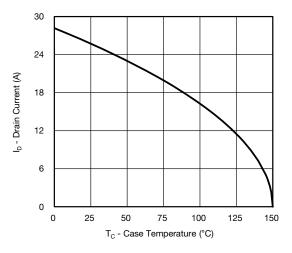
Single Pulse Power, Junction-to-Ambient



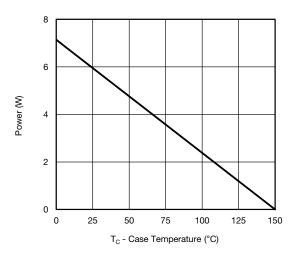


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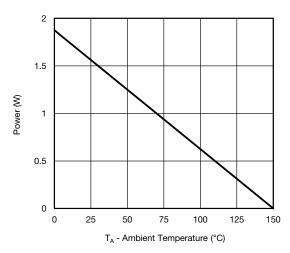
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Current Derating*







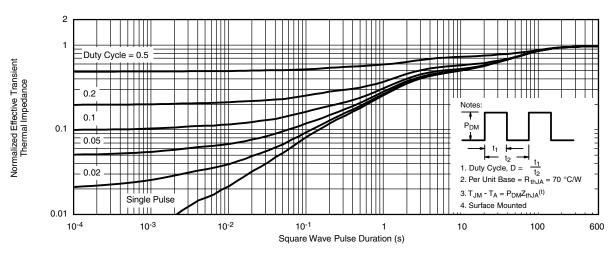
Power Derating, Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J(max.)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

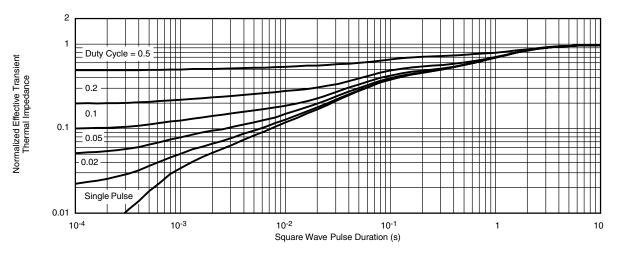
Si4101DY

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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?62828.



SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







	MILLIM	IETERS	INCHES			
DIM	Min	Max	Min	Max		
Α	1.35	1.75	0.053	0.069		
A ₁	0.10	0.20	0.004	0.008		
В	0.35	0.51	0.014	0.020		
С	0.19	0.25	0.0075	0.010		
D	4.80	5.00	0.189	0.196		
Е	3.80	4.00	0.150	0.157		
е	1.27	BSC	0.050) BSC		
Н	5.80	6.20	0.228	0.244		
h	0.25	0.50	0.010	0.020		
L	0.50	0.93	0.020	0.037		
q	0°	8°	0°	8°		
S	0.44	0.64	0.018	0.026		
ECN: C-06527-Rev. I. 11-Sep-06						

DWG: 5498

Document Number: 71192 www.vishay.com 11-Sep-06

LON NOTE



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)

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